



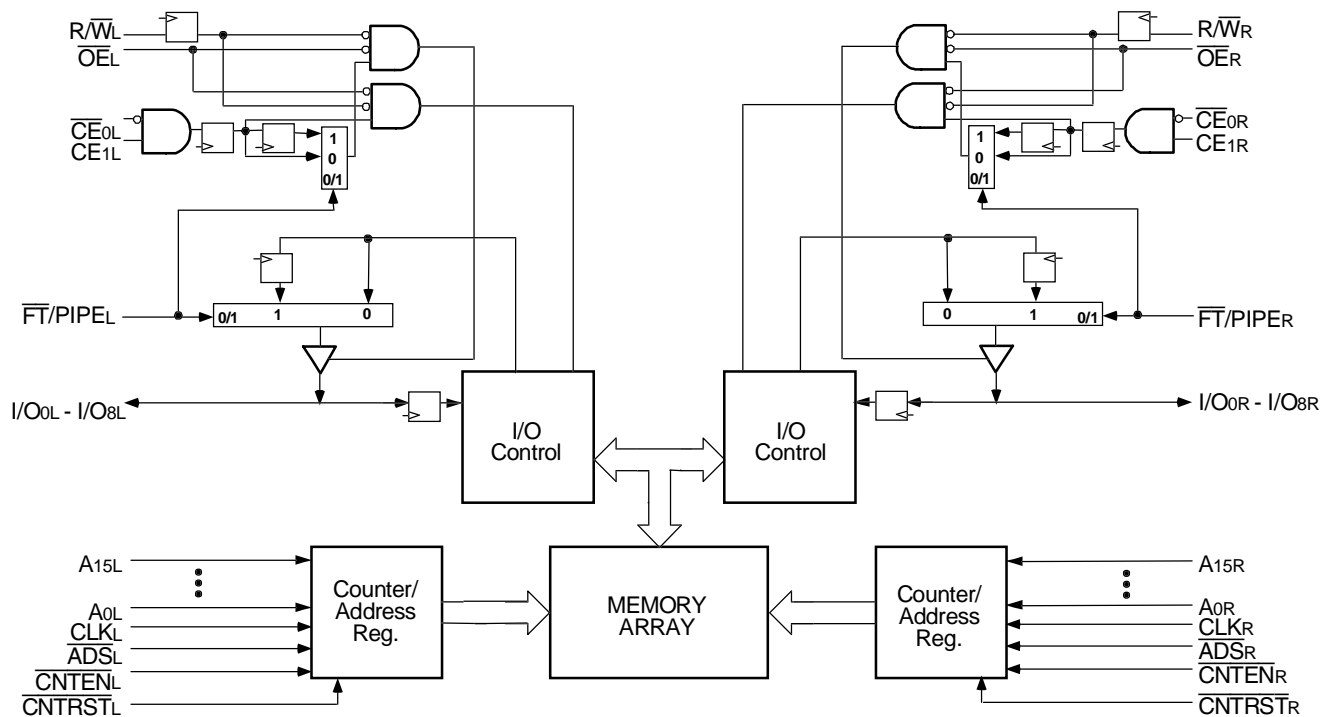
# HIGH-SPEED 64K x 9 SYNCHRONOUS PIPELINED DUAL-PORT STATIC RAM

**IDT709189L**

## Features

- ♦ True Dual-Ported memory cells which allow simultaneous access of the same memory location
- ♦ High-speed clock to data access
  - Commercial: 7.5/9/12ns (max.)
- ♦ Low-power operation
  - IDT709189L
  - Active: 1.2W (typ.)
  - Standby: 2.5mW (typ.)
- ♦ Flow-Through or Pipelined output mode on either Port via the  $\overline{\text{FT}}/\text{PIPE}$  pins
- ♦ Counter enable and reset features
- ♦ Dual chip enables allow for depth expansion without additional logic
- ♦ Full synchronous operation on both ports
  - 4ns setup to clock and 0ns hold on all control, data, and address inputs
  - Data input, address, and control registers
  - Fast 7.5ns clock to data out in the Pipelined output mode
  - Self-timed write allows fast cycle time
  - 12ns cycle time, 83MHz operation in Pipelined output mode
- ♦ TTL-compatible, single 5V ( $\pm 10\%$ ) power supply
- ♦ Industrial temperature range ( $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ ) is available for selected speeds
- ♦ Available in a 100-pin Thin Quad Flatpack (TQFP) package

## Functional Block Diagram



4848 drw 01

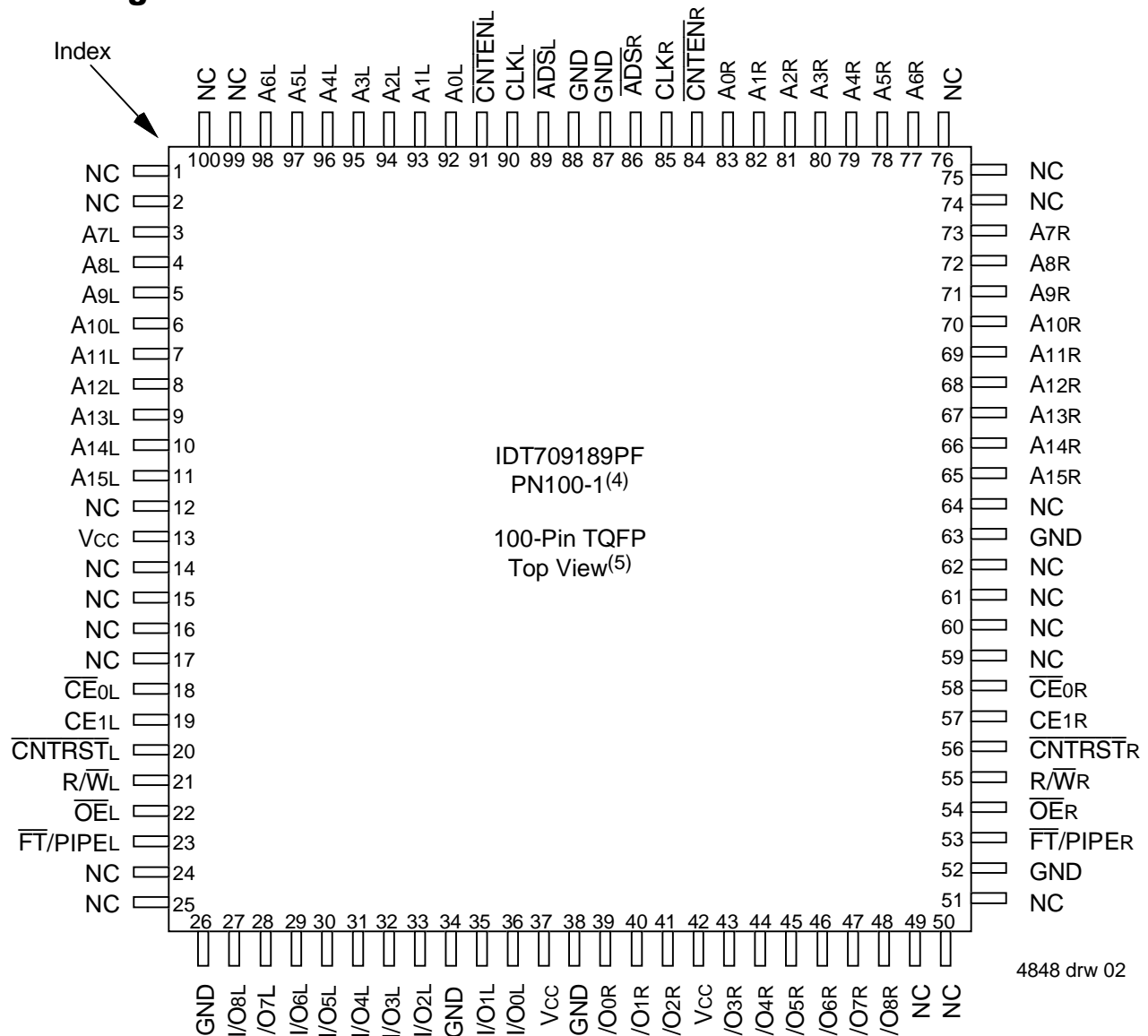
**JANUARY 2001**

## Description

The IDT709189 is a high-speed 64K x 9 bit synchronous Dual-Port RAM. The memory array utilizes Dual-Port memory cells to allow simultaneous access of any address from both ports. Registers on control, data, and address inputs provide minimal setup and hold times. The timing latitude provided by this approach allows systems to be designed with very short cycle times.

With an input data register, the IDT709189 has been optimized for applications having unidirectional or bidirectional data flow in bursts. An automatic power down feature, controlled by  $\overline{CE_0}$  and  $CE_1$ , permits the on-chip circuitry of each port to enter a very low standby power mode. Fabricated using IDT's CMOS high-performance technology, these devices typically operate on only 1.2W of power.

## Pin Configurations<sup>(1,2,3)</sup>



### NOTES:

1. All Vcc pins must be connected to power supply.
2. All GND pins must be connected to ground.
3. Package body is approximately 14mm x 14mm x 1.4mm
4. This package code is used to reference the package diagram.
5. This text does not indicate orientation of the actual part-marking.

## Pin Names

| Left Port                        | Right Port                       | Names                 |
|----------------------------------|----------------------------------|-----------------------|
| $\overline{CE}_{0L}$ , $CE_{1L}$ | $\overline{CE}_{0R}$ , $CE_{1R}$ | Chip Enables          |
| $R/\overline{W}_L$               | $R/\overline{W}_R$               | Read/Write Enable     |
| $\overline{OE}_L$                | $\overline{OE}_R$                | Output Enable         |
| $A_{0L}$ - $A_{15L}$             | $A_{0R}$ - $A_{15R}$             | Address               |
| $I/O_{0L}$ - $I/O_{8L}$          | $I/O_{0R}$ - $I/O_{8R}$          | Data Input/Output     |
| $CLK_L$                          | $CLK_R$                          | Clock                 |
| $\overline{ADS}_L$               | $\overline{ADS}_R$               | Address Strobe        |
| $\overline{CNTEN}_L$             | $\overline{CNTEN}_R$             | Counter Enable        |
| $\overline{CNTRST}_L$            | $\overline{CNTRST}_R$            | Counter Reset         |
| $\overline{FT}/PIPE_L$           | $\overline{FT}/PIPE_R$           | Flow-Through/Pipeline |
| $V_{CC}$                         |                                  | Power                 |
| $GND$                            |                                  | Ground                |

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## Truth Table I—Read/Write and Enable Control<sup>(1,2,3)</sup>

| $\overline{OE}$ | CLK | $\overline{CE}_0$ | $CE_1$ | $R/\overline{W}$ | $I/O_{0-8}$  | Mode                  |
|-----------------|-----|-------------------|--------|------------------|--------------|-----------------------|
| X               | ↑   | H                 | X      | X                | High-Z       | Deselected—Power Down |
| X               | ↑   | X                 | L      | X                | High-Z       | Deselected—Power Down |
| X               | ↑   | L                 | H      | L                | $DATA_{IN}$  | Write                 |
| L               | ↑   | L                 | H      | H                | $DATA_{OUT}$ | Read                  |
| H               | X   | L                 | H      | X                | High-Z       | Outputs Disabled      |

4848 tbl 02

### NOTES:

- "H" =  $V_{IH}$ , "L" =  $V_{IL}$ , "X" = Don't Care.
- $\overline{ADS}$ ,  $\overline{CNTEN}$ ,  $\overline{CNTRST}$  = X.
- $\overline{OE}$  is an asynchronous input signal.

## Truth Table II—Address Counter Control<sup>(1,2,6)</sup>

| Address | Previous Address | Addr Used | $CLK^{(6)}$ | $\overline{ADS}$ | $\overline{CNTEN}$ | $\overline{CNTRST}$ | $I/O^{(8)}$ | Mode                                       |
|---------|------------------|-----------|-------------|------------------|--------------------|---------------------|-------------|--------------------------------------------|
| X       | X                | 0         | ↑           | X                | X                  | L                   | $D/O(0)$    | Counter Reset to Address 0                 |
| $A_n$   | X                | $A_n$     | ↑           | $L^{(4)}$        | X                  | H                   | $D/O(n)$    | External Address Utilized                  |
| $A_n$   | $A_p$            | $A_p$     | ↑           | H                | H                  | H                   | $D/O(n)$    | External Address Blocked—Counter Disabled  |
| X       | $A_p$            | $A_p + 1$ | ↑           | H                | $L^{(5)}$          | H                   | $D/O(n+1)$  | Counter Enable—Internal Address Generation |

4848 tbl 03

### NOTES:

- "H" =  $V_{IH}$ , "L" =  $V_{IL}$ , "X" = Don't Care.
- $\overline{CE}_0$  and  $\overline{OE}$  =  $V_{IL}$ ;  $CE_1$  and  $R/\overline{W}$  =  $V_{IH}$ .
- Outputs configured in Flow-Through Output mode: if outputs are in Pipelined mode the data out will be delayed by one cycle.
- $\overline{ADS}$  is independent of all other signals including  $\overline{CE}_0$  and  $CE_1$ .
- The address counter advances if  $\overline{CNTEN} = V_{IL}$  on the rising edge of CLK, regardless of all other signals including  $\overline{CE}_0$  and  $CE_1$ .
- While an external address is being loaded ( $\overline{ADS} = V_{IL}$ ),  $R/\overline{W} = V_{IH}$  is recommended to ensure data is not written arbitrarily.

## Recommended Operating Temperature and Supply Voltage<sup>(1)</sup>

| Grade      | Ambient Temperature <sup>(2)</sup> | GND | V <sub>CC</sub> |
|------------|------------------------------------|-----|-----------------|
| Commercial | 0°C to +70°C                       | 0V  | 5.0V $\pm$ 10%  |
| Industrial | -40°C to +85°C                     | 0V  | 5.0V $\pm$ 10%  |

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### NOTES:

- Industrial temperature: for specific speeds, packages and powers contact your sales office.
- This is the parameter T<sub>A</sub>. This is the "instant on" case temperature.

## Recommended DC Operating Conditions

| Symbol          | Parameter          | Min.                | Typ. | Max.               | Unit |
|-----------------|--------------------|---------------------|------|--------------------|------|
| V <sub>CC</sub> | Supply Voltage     | 4.5                 | 5.0  | 5.5                | V    |
| GND             | Ground             | 0                   | 0    | 0                  | V    |
| V <sub>IH</sub> | Input High Voltage | 2.2                 | —    | 6.0 <sup>(1)</sup> | V    |
| V <sub>IL</sub> | Input Low Voltage  | -0.5 <sup>(2)</sup> | —    | 0.8                | V    |

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### NOTES:

- V<sub>TERM</sub> must not exceed V<sub>CC</sub> + 10%.
- V<sub>IL</sub>  $\geq$  -1.5V for pulse width less than 10ns.

## Absolute Maximum Ratings<sup>(1)</sup>

| Symbol                           | Rating                               | Commercial & Industrial | Unit |
|----------------------------------|--------------------------------------|-------------------------|------|
| V <sub>TERM</sub> <sup>(2)</sup> | Terminal Voltage with Respect to GND | -0.5 to +7.0            | V    |
| T <sub>BIAS</sub>                | Temperature Under Bias               | -55 to +125             | °C   |
| T <sub>STG</sub>                 | Storage Temperature                  | -65 to +150             | °C   |
| I <sub>OUT</sub>                 | DC Output Current                    | 50                      | mA   |

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### NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- V<sub>TERM</sub> must not exceed V<sub>CC</sub> + 10% for more than 25% of the cycle time or 10ns maximum, and is limited to  $\leq$  20mA for the period of V<sub>TERM</sub>  $\geq$  V<sub>CC</sub> + 10%.

## Capacitance<sup>(1)</sup>

(T<sub>A</sub> = +25°C, f = 1.0MHz)

| Symbol                          | Parameter          | Conditions <sup>(2)</sup> | Max. | Unit |
|---------------------------------|--------------------|---------------------------|------|------|
| C <sub>IN</sub>                 | Input Capacitance  | V <sub>IN</sub> = 3dV     | 9    | pF   |
| C <sub>OUT</sub> <sup>(3)</sup> | Output Capacitance | V <sub>OUT</sub> = 3dV    | 10   | pF   |

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### NOTES:

- These parameters are determined by device characterization, but are not production tested.
- 3dV references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.
- C<sub>OUT</sub> also references C<sub>IO</sub>.

## DC Electrical Characteristics Over the Operating Temperature Supply Voltage Range (V<sub>CC</sub> = 5.0V $\pm$ 10%)

| Symbol          | Parameter                            | Test Conditions                                                                                                     | 709189L |      | Unit |
|-----------------|--------------------------------------|---------------------------------------------------------------------------------------------------------------------|---------|------|------|
|                 |                                      |                                                                                                                     | Min.    | Max. |      |
| I <sub>L</sub>  | Input Leakage Current <sup>(1)</sup> | V <sub>CC</sub> = 5.5V, V <sub>IN</sub> = 0V to V <sub>CC</sub>                                                     | —       | 5    | μA   |
| I <sub>LO</sub> | Output Leakage Current               | $\overline{CE_0}$ = V <sub>IH</sub> or CE <sub>1</sub> = V <sub>IL</sub> , V <sub>OUT</sub> = 0V to V <sub>CC</sub> | —       | 5    | μA   |
| V <sub>OL</sub> | Output Low Voltage                   | I <sub>OL</sub> = +4mA                                                                                              | —       | 0.4  | V    |
| V <sub>OH</sub> | Output High Voltage                  | I <sub>OH</sub> = -4mA                                                                                              | 2.4     | —    | V    |

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### NOTE:

- At V<sub>CC</sub>  $\leq$  2.0V input leakages are undefined.

## DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range<sup>(3,6)</sup> ( $V_{CC} = 5V \pm 10\%$ )

| Symbol           | Parameter                                                | Test Condition                                                                                                                                                                              | Version | 709189L7<br>Com'l Only |      | 709189L9<br>Com'l Only |      | 709189L12<br>Com'l Only |      | Unit |
|------------------|----------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------|------------------------|------|------------------------|------|-------------------------|------|------|
|                  |                                                          |                                                                                                                                                                                             |         | Typ. <sup>(4)</sup>    | Max. | Typ. <sup>(4)</sup>    | Max. | Typ. <sup>(4)</sup>     | Max. |      |
| I <sub>CC</sub>  | Dynamic Operating Current<br>(Both Ports Active)         | $\overline{CE}_L$ and $\overline{CE}_R = V_{IL}$<br>Outputs Disabled<br>$f = f_{MAX}^{(1)}$                                                                                                 | COM'L L | 275                    | 465  | 250                    | 400  | 230                     | 355  | mA   |
|                  |                                                          |                                                                                                                                                                                             | IND L   | —                      | —    | —                      | —    | —                       | —    |      |
| I <sub>SB1</sub> | Standby Current<br>(Both Ports - TTL Level Inputs)       | $\overline{CE}_L = \overline{CE}_R = V_{IH}$<br>$f = f_{MAX}^{(1)}$                                                                                                                         | COM'L L | 95                     | 150  | 80                     | 135  | 70                      | 110  | mA   |
|                  |                                                          |                                                                                                                                                                                             | IND L   | —                      | —    | —                      | —    | —                       | —    |      |
| I <sub>SB2</sub> | Standby Current<br>(One Port - TTL Level Inputs)         | $\overline{CE}^*_{A} = V_{IL}$ and<br>$\overline{CE}^*_{B} = V_{IH}^{(3)}$<br>Active Port Outputs Disabled, $f = f_{MAX}^{(1)}$                                                             | COM'L L | 200                    | 295  | 175                    | 275  | 150                     | 240  | mA   |
|                  |                                                          |                                                                                                                                                                                             | IND L   | —                      | —    | —                      | —    | —                       | —    |      |
| I <sub>SB3</sub> | Full Standby Current<br>(Both Ports - CMOS Level Inputs) | Both Ports $CE_R$ and<br>$\overline{CE}_L \geq V_{CC} - 0.2V$<br>$V_N \geq V_{CC} - 0.2V$ or<br>$V_N \leq 0.2V$ , $f = 0^{(2)}$                                                             | COM'L L | 0.5                    | 3    | 0.5                    | 3    | 0.5                     | 3    | mA   |
|                  |                                                          |                                                                                                                                                                                             | IND L   | —                      | —    | —                      | —    | —                       | —    |      |
| I <sub>SB4</sub> | Full Standby Current<br>(One Port - CMOS Level Inputs)   | $\overline{CE}^*_{A} \leq 0.2V$ and<br>$\overline{CE}^*_{B} \geq V_{CC} - 0.2V^{(6)}$<br>$V_N \geq V_{CC} - 0.2V$ or<br>$V_N \leq 0.2V$ , Active Port Outputs Disabled, $f = f_{MAX}^{(1)}$ | COM'L L | 190                    | 290  | 170                    | 270  | 140                     | 225  | mA   |
|                  |                                                          |                                                                                                                                                                                             | IND L   | —                      | —    | —                      | —    | —                       | —    |      |

4848 tbl 09

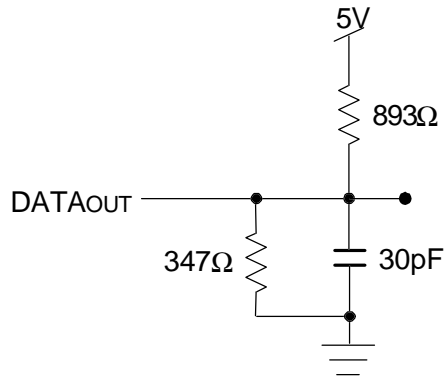
### NOTES:

- At  $f = f_{MAX}$ , address and control lines (except Output Enable) are cycling at the maximum frequency clock cycle of  $1/t_{cyc}$ , using "AC TEST CONDITIONS" at input levels of GND to 3V.
- $f = 0$  means no address, clock, or control lines change. Applies only to input at CMOS level standby.
- Port "A" may be either left or right port. Port "B" is the opposite from port "A".
- $V_{CC} = 5V$ ,  $T_A = 25^\circ C$  for Typ, and are not production tested.  $I_{CC}(f=0) = 150mA$  (Typ).
- $CE_X = V_{IL}$  means  $\overline{CE}_{0X} = V_{IL}$  and  $CE_{1X} = V_{IH}$   
 $CE_X = V_{IH}$  means  $\overline{CE}_{0X} = V_{IH}$  or  $CE_{1X} = V_{IL}$   
 $CE_X \leq 0.2V$  means  $\overline{CE}_{0X} \leq 0.2V$  and  $CE_{1X} \geq V_{CC} - 0.2V$   
 $CE_X \geq V_{CC} - 0.2V$  means  $\overline{CE}_{0X} \geq V_{CC} - 0.2V$  or  $CE_{1X} \leq 0.2V$   
"X" represents "L" for left port or "R" for right port.
- Industrial temperature: for specific speeds, packages and powers contact your sales office.

## AC Test Conditions

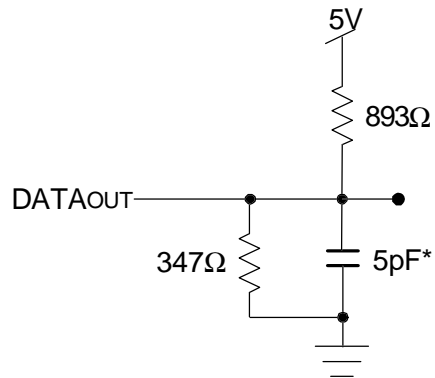
|                               |                   |
|-------------------------------|-------------------|
| Input Pulse Levels            | GND to 3.0V       |
| Input Rise/Fall Times         | 3ns Max.          |
| Input Timing Reference Levels | 1.5V              |
| Output Reference Levels       | 1.5V              |
| Output Load                   | Figures 1,2 and 3 |

4848 tbl 10



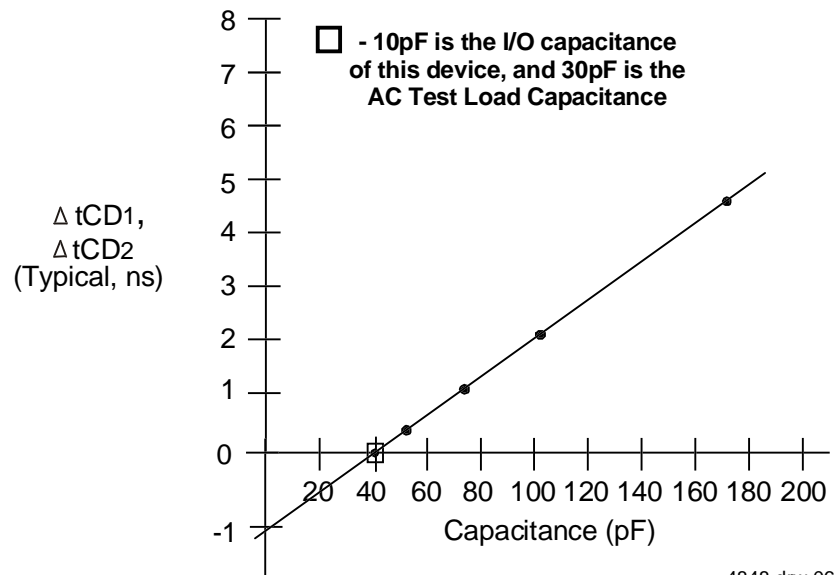
4848 drw 04

Figure 1. AC Output Test load.



4848 drw 05

Figure 2. Output Test Load  
(For  $t_{CKLZ}$ ,  $t_{CKHZ}$ ,  $t_{OLZ}$ , and  $t_{OHZ}$ ).  
\*Including scope and jig.



4848 drw 06

Figure 3. Typical Output Derating (Lumped Capacitive Load).

## AC Electrical Characteristics Over the Operating Temperature Range (Read and Write Cycle Timing)<sup>(3,4)</sup> ( $V_{CC} = 5V \pm 10\%$ , $T_A = 0^\circ C$ to $+70^\circ C$ )

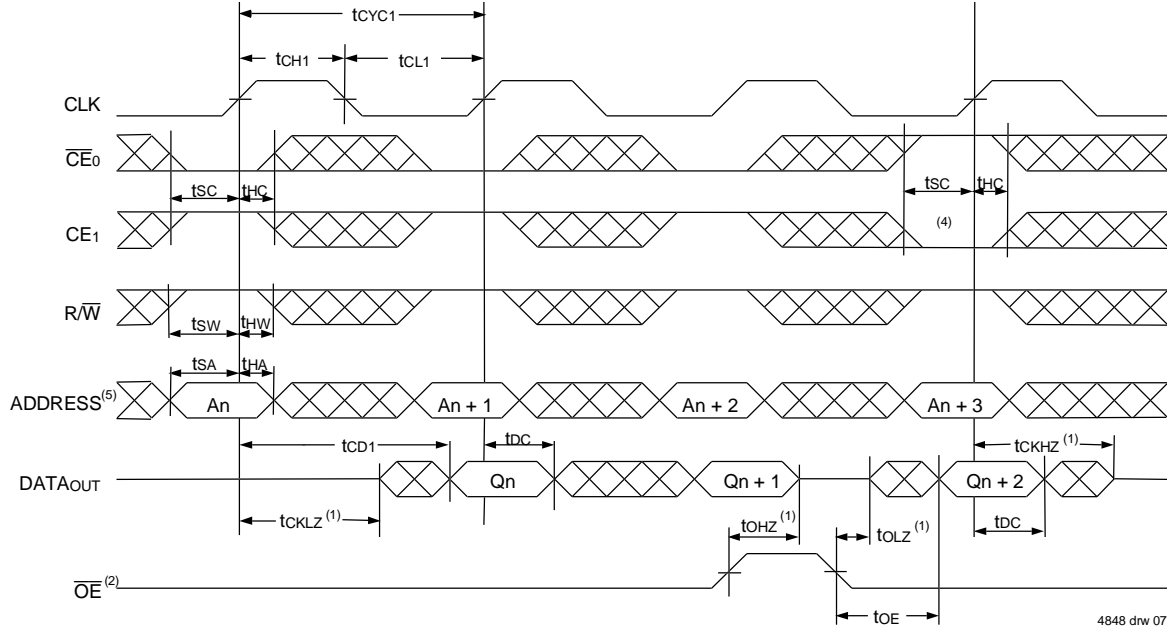
| Symbol                    | Parameter                                         | 709189L7<br>Com'l Only |      | 709189L9<br>Com'l Only |      | 709189L12<br>Com'l Only |      | Unit |
|---------------------------|---------------------------------------------------|------------------------|------|------------------------|------|-------------------------|------|------|
|                           |                                                   | Min.                   | Max. | Min.                   | Max. | Min.                    | Max. |      |
| t <sub>CYC1</sub>         | Clock Cycle Time (Flow-Through) <sup>(2)</sup>    | 22                     | —    | 25                     | —    | 30                      | —    | ns   |
| t <sub>CYC2</sub>         | Clock Cycle Time (Pipelined) <sup>(2)</sup>       | 12                     | —    | 15                     | —    | 20                      | —    | ns   |
| t <sub>CH1</sub>          | Clock High Time (Flow-Through) <sup>(2)</sup>     | 7.5                    | —    | 12                     | —    | 12                      | —    | ns   |
| t <sub>CL1</sub>          | Clock Low Time (Flow-Through) <sup>(2)</sup>      | 7.5                    | —    | 12                     | —    | 12                      | —    | ns   |
| t <sub>CH2</sub>          | Clock High Time (Pipelined) <sup>(2)</sup>        | 5                      | —    | 6                      | —    | 8                       | —    | ns   |
| t <sub>CL2</sub>          | Clock Low Time (Pipelined) <sup>(2)</sup>         | 5                      | —    | 6                      | —    | 8                       | —    | ns   |
| t <sub>R</sub>            | Clock Rise Time                                   | —                      | 3    | —                      | 3    | —                       | 3    | ns   |
| t <sub>F</sub>            | Clock Fall Time                                   | —                      | 3    | —                      | 3    | —                       | 3    | ns   |
| t <sub>SA</sub>           | Address Setup Time                                | 4                      | —    | 4                      | —    | 4                       | —    | ns   |
| t <sub>HA</sub>           | Address Hold Time                                 | 0                      | —    | 1                      | —    | 1                       | —    | ns   |
| t <sub>SC</sub>           | Chip Enable Setup Time                            | 4                      | —    | 4                      | —    | 4                       | —    | ns   |
| t <sub>HC</sub>           | Chip Enable Hold Time                             | 0                      | —    | 1                      | —    | 1                       | —    | ns   |
| t <sub>SW</sub>           | R/W Setup Time                                    | 4                      | —    | 4                      | —    | 4                       | —    | ns   |
| t <sub>HW</sub>           | R/W Hold Time                                     | 0                      | —    | 1                      | —    | 1                       | —    | ns   |
| t <sub>SD</sub>           | Input Data Setup Time                             | 4                      | —    | 4                      | —    | 4                       | —    | ns   |
| t <sub>HD</sub>           | Input Data Hold Time                              | 0                      | —    | 1                      | —    | 1                       | —    | ns   |
| t <sub>SAD</sub>          | $\overline{ADS}$ Setup Time                       | 4                      | —    | 4                      | —    | 4                       | —    | ns   |
| t <sub>HAD</sub>          | $\overline{ADS}$ Hold Time                        | 0                      | —    | 1                      | —    | 1                       | —    | ns   |
| t <sub>SCN</sub>          | $\overline{CNTEN}$ Setup Time                     | 4                      | —    | 4                      | —    | 4                       | —    | ns   |
| t <sub>HCN</sub>          | $\overline{CNTEN}$ Hold Time                      | 0                      | —    | 1                      | —    | 1                       | —    | ns   |
| t <sub>SRST</sub>         | $\overline{CNTRST}$ Setup Time                    | 4                      | —    | 4                      | —    | 4                       | —    | ns   |
| t <sub>HST</sub>          | $\overline{CNTRST}$ Hold Time                     | 0                      | —    | 1                      | —    | 1                       | —    | ns   |
| t <sub>OE</sub>           | Output Enable to Data Valid                       | —                      | 9    | —                      | 12   | —                       | 12   | ns   |
| t <sub>OLZ</sub>          | Output Enable to Output Low-Z <sup>(1)</sup>      | 2                      | —    | 2                      | —    | 2                       | —    | ns   |
| t <sub>OHZ</sub>          | Output Enable to Output High-Z <sup>(1)</sup>     | 1                      | 7    | 1                      | 7    | 1                       | 7    | ns   |
| t <sub>CD1</sub>          | Clock to Data Valid (Flow-Through) <sup>(2)</sup> | —                      | 18   | —                      | 20   | —                       | 25   | ns   |
| t <sub>CD2</sub>          | Clock to Data Valid (Pipelined) <sup>(2)</sup>    | —                      | 7.5  | —                      | 9    | —                       | 12   | ns   |
| t <sub>DC</sub>           | Data Output Hold After Clock High                 | 2                      | —    | 2                      | —    | 2                       | —    | ns   |
| t <sub>CKHZ</sub>         | Clock High to Output High-Z <sup>(1)</sup>        | 2                      | 9    | 2                      | 9    | 2                       | 9    | ns   |
| t <sub>CKLZ</sub>         | Clock High to Output Low-Z <sup>(1)</sup>         | 2                      | —    | 2                      | —    | 2                       | —    | ns   |
| <b>Port-to-Port Delay</b> |                                                   |                        |      |                        |      |                         |      |      |
| t <sub>CWDD</sub>         | Write Port Clock High to Read Data Delay          | —                      | 28   | —                      | 35   | —                       | 40   | ns   |
| t <sub>CCS</sub>          | Clock-to-Clock Setup Time                         | —                      | 10   | —                      | 15   | —                       | 15   | ns   |

### NOTES:

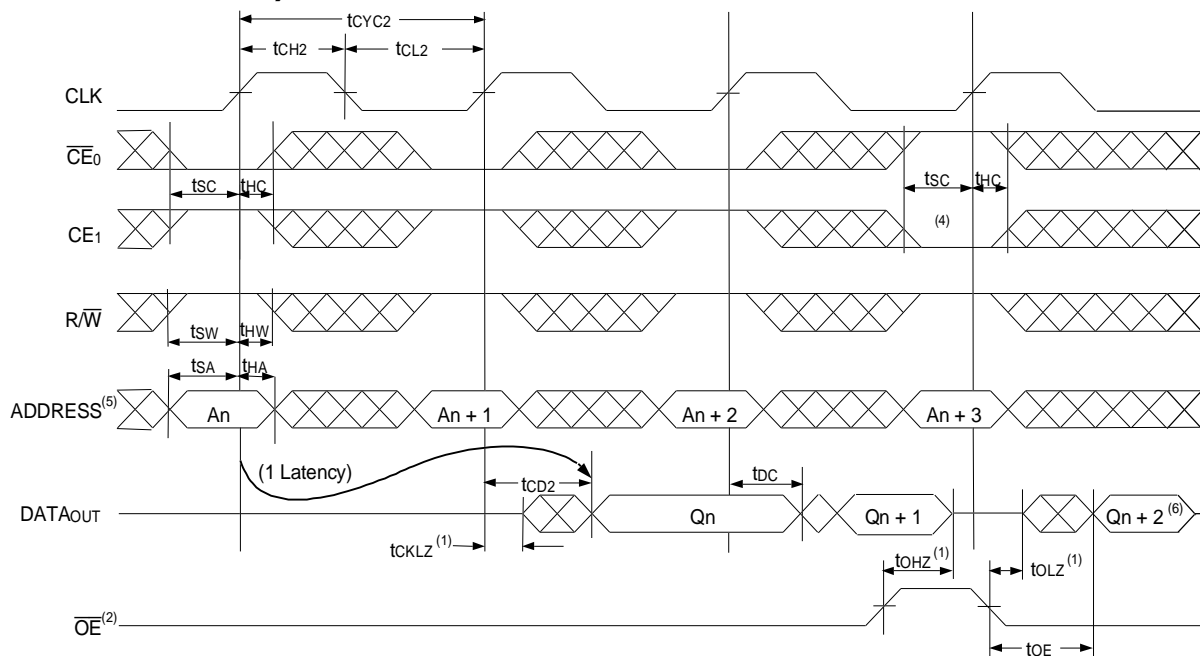
1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2). This parameter is guaranteed by device characterization, but is not production tested.
2. The Pipelined output parameters (t<sub>CYC2</sub>, t<sub>CD2</sub>) to either the Left or Right ports when  $\overline{FT}/PIPE = V_{IH}$ . Flow-Through parameters (t<sub>CYC1</sub>, t<sub>CD1</sub>) apply when  $\overline{FT}/PIPE = V_{IL}$  for that port.
3. All input signals are synchronous with respect to the clock except for the asynchronous Output Enable ( $\overline{OE}$ ),  $\overline{FT}/PIPE_R$  and  $\overline{FT}/PIPE_L$ .
4. Industrial temperature: for specific speeds, packages and powers contact your sales office.

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## Timing Waveform of Read Cycle for Flow-Through Output ( $\overline{FT}/PIPE^X = V_{IL}$ )<sup>(3,6)</sup>



## Timing Waveform of Read Cycle for Pipelined Operation ( $\overline{FT}/PIPE^X = V_{IH}$ )<sup>(3,6)</sup>

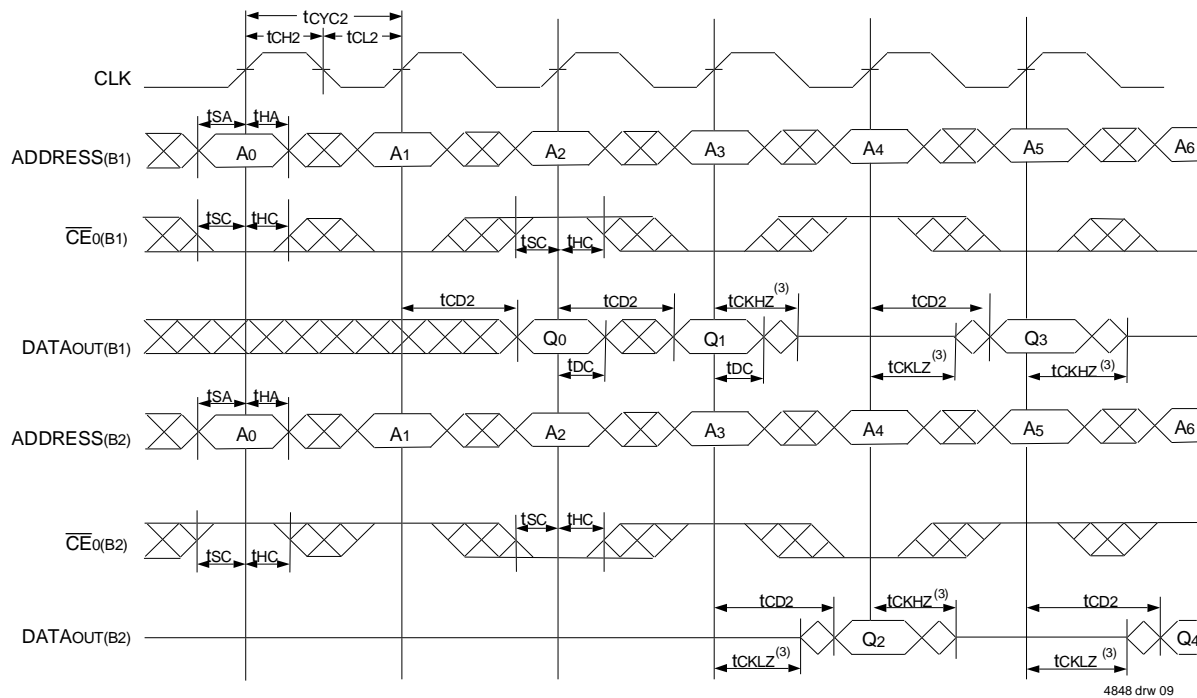


### NOTES:

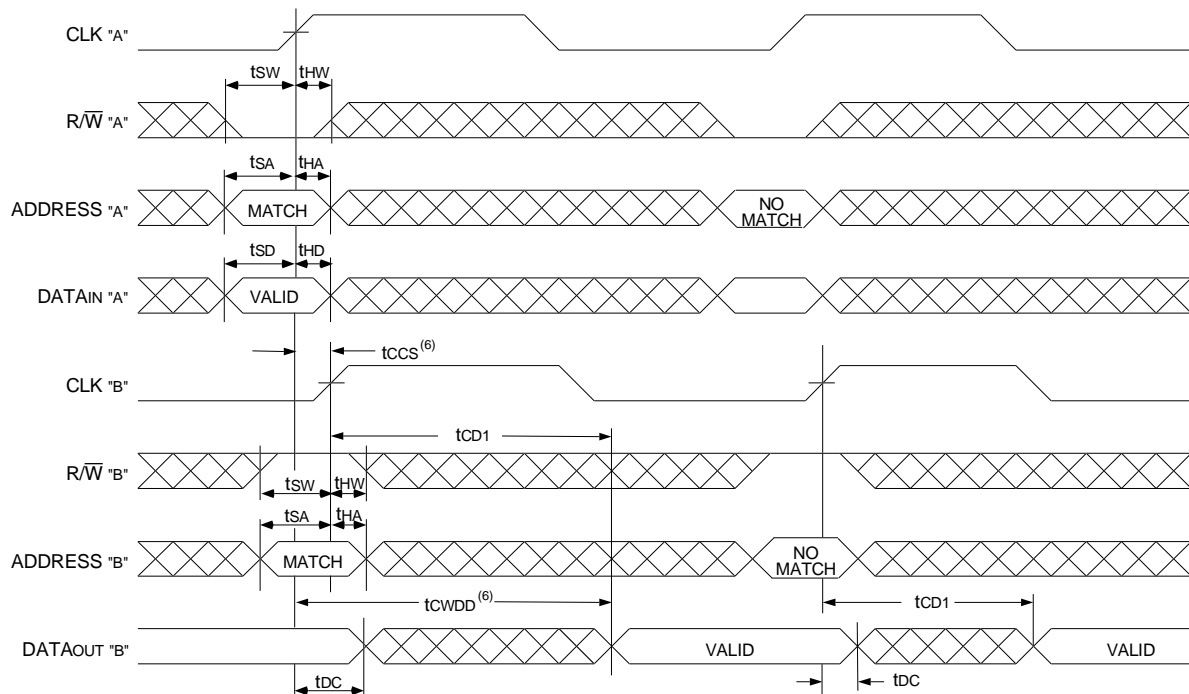
1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
2.  $\overline{OE}$  is asynchronously controlled; all other inputs are synchronous to the rising clock edge.
3.  $\overline{ADS} = V_{IL}$ ,  $\overline{CNTEN}$  and  $\overline{CNRST} = V_{IH}$ .
4. The output is disabled (High-Impedance state) by  $\overline{CE}_0 = V_{IH}$  or  $CE_1 = V_{IL}$  following the next rising edge of the clock. Refer to Truth Table 1.
5. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
6. "X" here denotes Left or Right port. The diagram is with respect to that port.



## Timing Waveform of a Bank Select Pipelined Read<sup>(1,2)</sup>



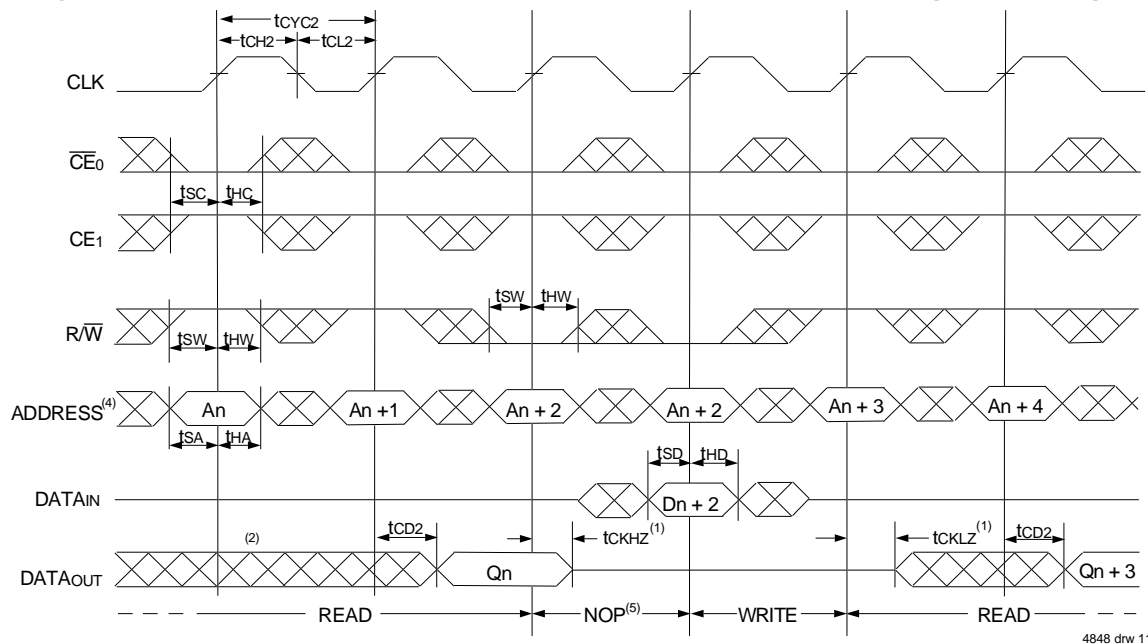
## Timing Waveform of Write with Port-to-Port Flow-Through Read<sup>(4,5,7)</sup>



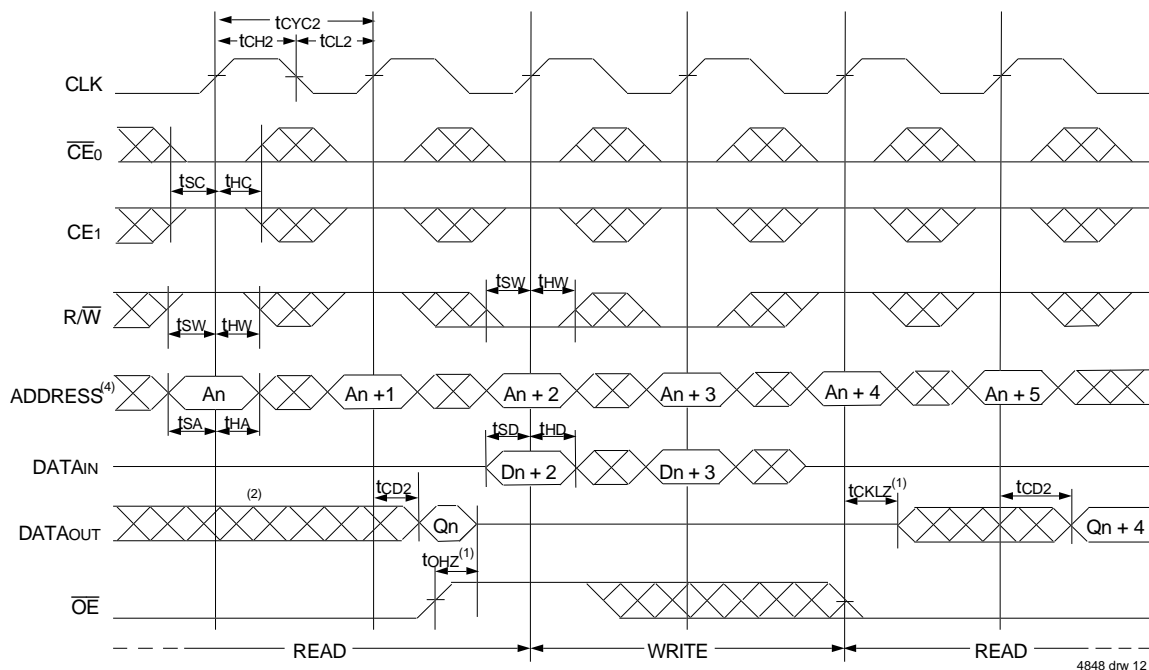
### NOTES:

1. B1 Represents Bank #1; B2 Represents Bank #2. Each Bank consists of one IDT709189 for this waveform, and are setup for depth expansion in this example. ADDRESS(B1) = ADDRESS(B2) in this situation.
2.  $\overline{OE}$  and  $\overline{ADS} = V_{IL}$ ;  $CE_1(B1)$ ,  $CE_1(B2)$ ,  $R/\overline{W}$ ,  $\overline{CNTEN}$ , and  $\overline{CNTRST} = V_{IH}$ .
3. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
4.  $\overline{CE}_0$  and  $\overline{ADS} = V_{IL}$ ;  $CE_1$ ,  $\overline{CNTEN}$ , and  $\overline{CNTRST} = V_{IH}$ .
5.  $\overline{OE} = V_{IL}$  for the Right Port, which is being read from.  $\overline{OE} = V_{IH}$  for the Left Port, which is being written to.
6. If  $t_{CCS} \leq$  maximum specified, then data from right port READ is not valid until the maximum specified for  $t_{CWD}$ . If  $t_{CCS} >$  maximum specified, then data from right port READ is not valid until  $t_{CCS} + t_{CD1}$ .  $t_{CWD}$  does not apply in this case.
7. All timing is the same for both Left and Right ports. Port "A" may be either Left or Right port. Port "B" is the opposite from Port "A".

### Timing Waveform of Pipelined Read-to-Write-to-Read ( $\overline{OE} = V_{IL}$ )<sup>(3)</sup>



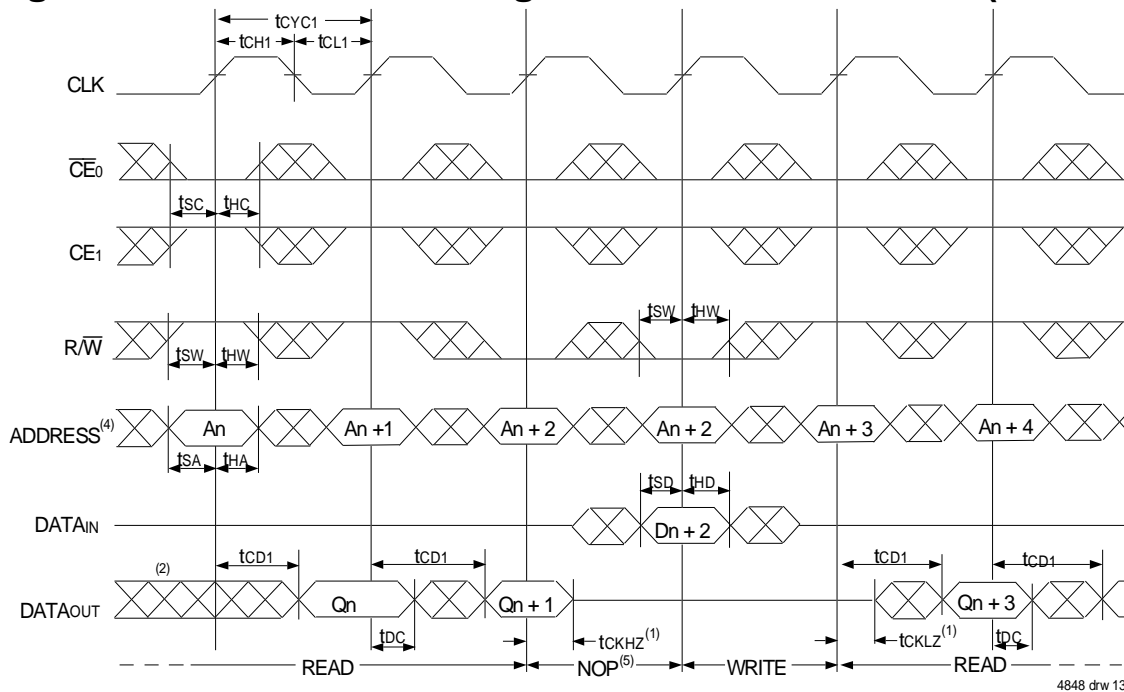
### Timing Waveform of Pipelined Read-to-Write-to-Read ( $\overline{\text{OE}}$ Controlled)<sup>(3)</sup>



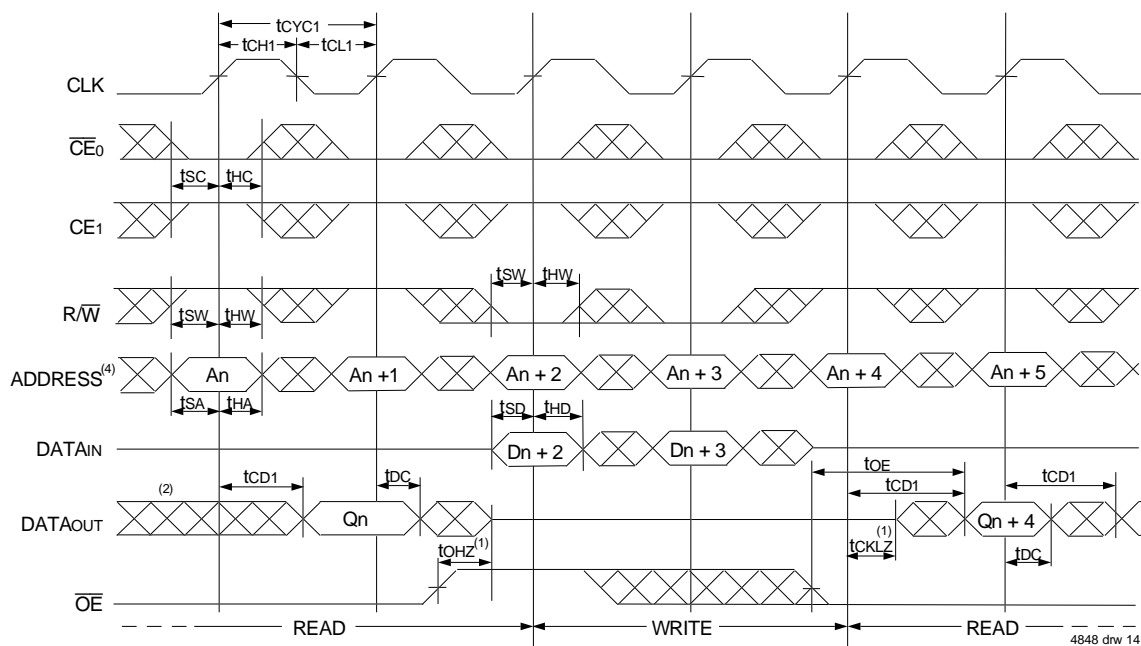
**NOTES:**

1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
2. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
3.  $\overline{CE_0}$  and  $ADS = V_{IL}$ ;  $CE_1$ ,  $\overline{CNTEN}$ , and  $\overline{CNTRST} = V_{IH}$ . "NOP" is "No Operation".
4. Addresses do not have to be accessed sequentially since  $ADS = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
5. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

### Timing Waveform of Flow-Through Read-to-Write-to-Read ( $\overline{OE} = V_{IL}$ )<sup>(3)</sup>



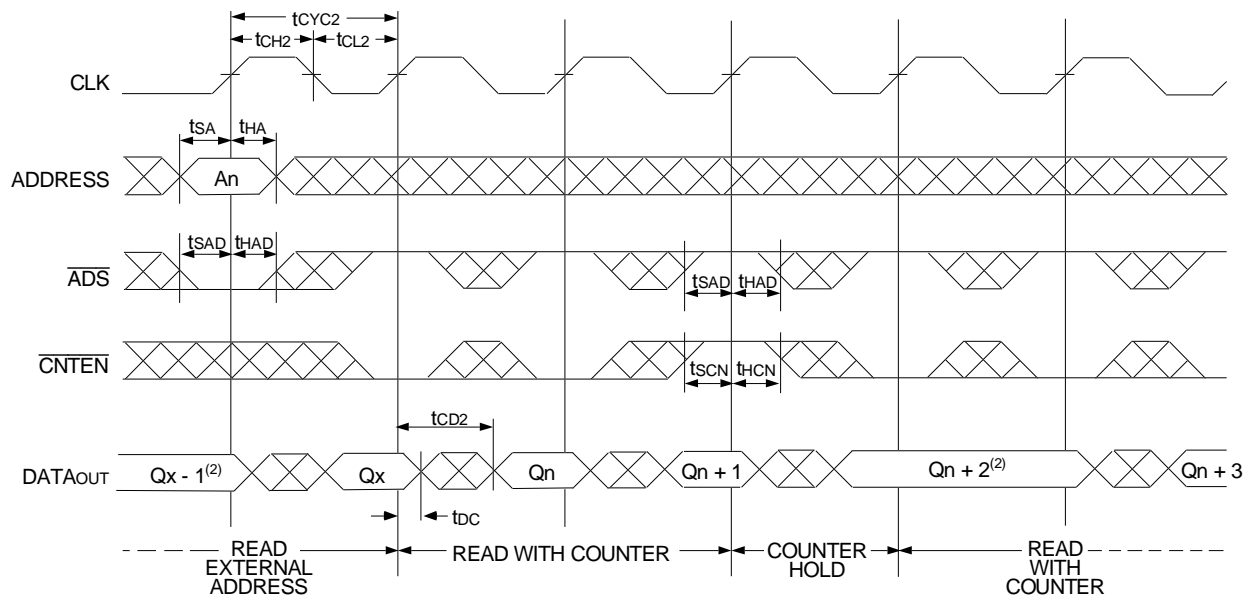
### Timing Waveform of Flow-Through Read-to-Write-to-Read ( $\overline{\text{OE}}$ Controlled)<sup>(3)</sup>



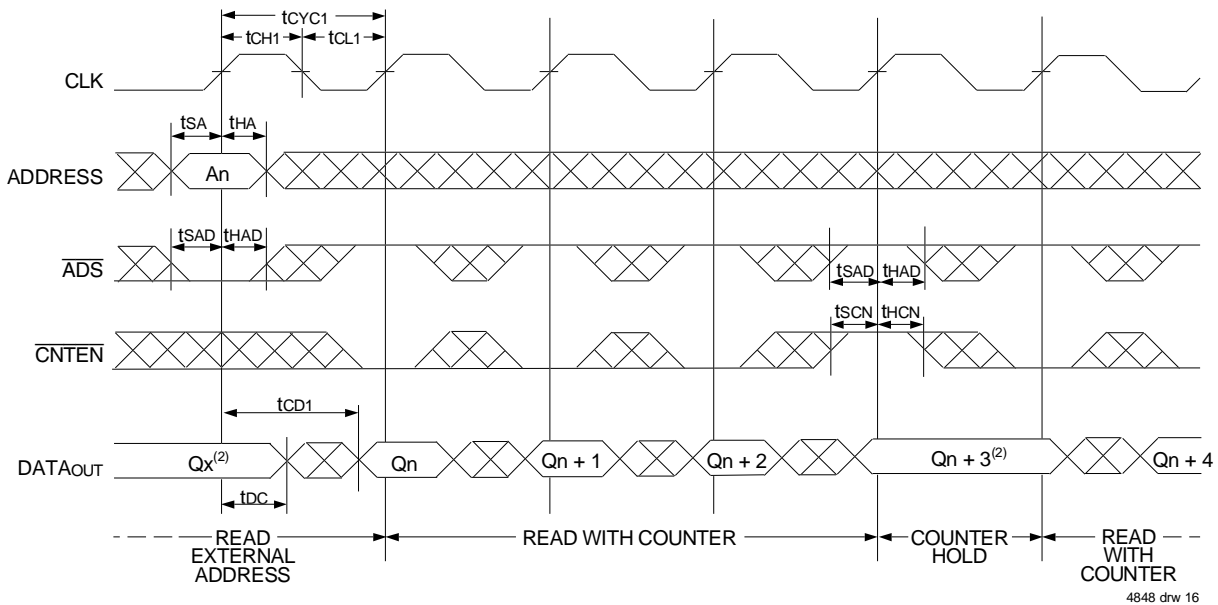
**NOTES:**

1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
2. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
3.  $\overline{CE_0}$  and  $\overline{ADS} = V_{IL}$ ;  $\overline{CE_1}$ ,  $\overline{CNTEN}$ , and  $\overline{CNTRST} = V_{IH}$ . "NOP" is "No Operation".
4. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
5. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

## Timing Waveform of Pipelined Read with Address Counter Advance<sup>(1)</sup>



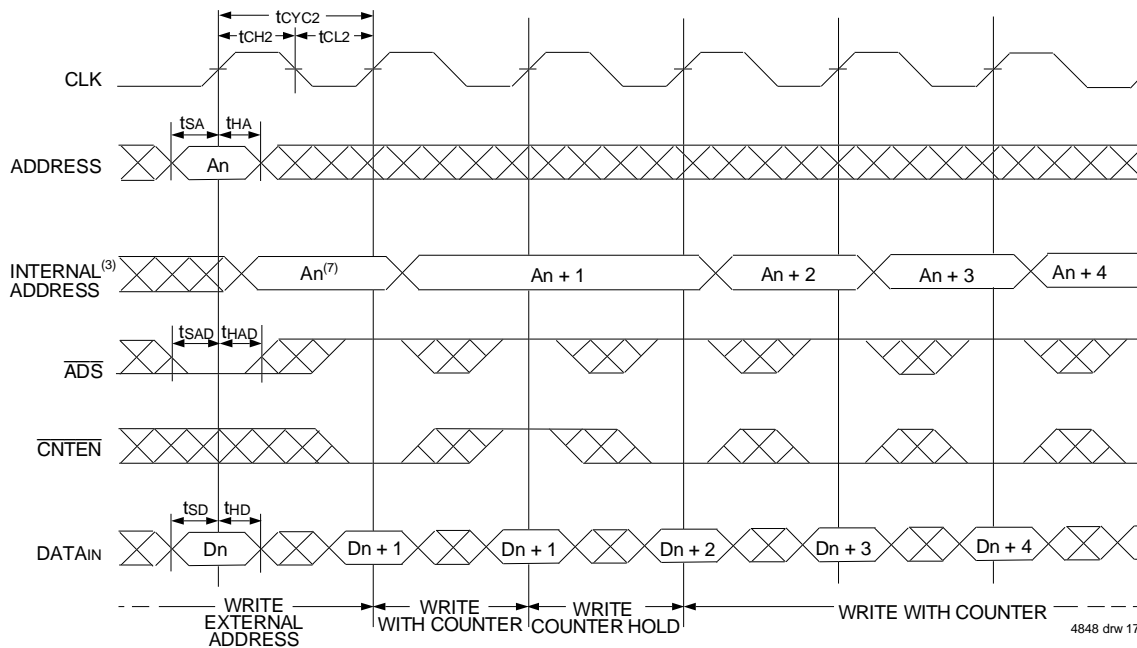
## Timing Waveform of Flow-Through Read with Address Counter Advance<sup>(1)</sup>



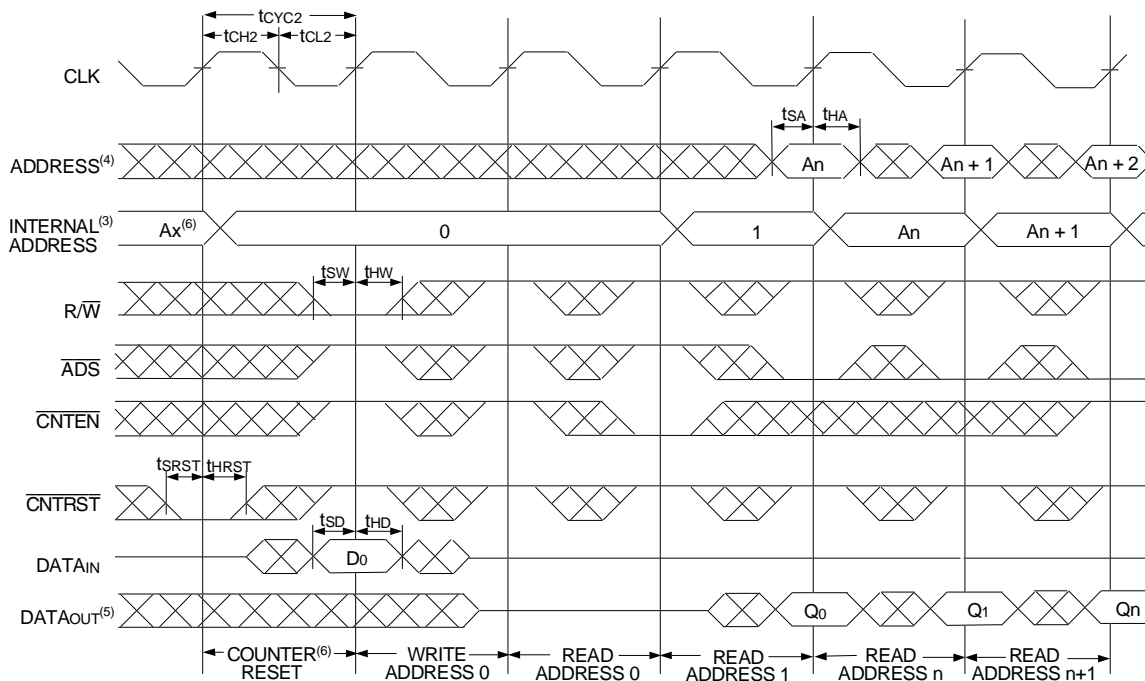
### NOTES:

1.  $\overline{CE}_0$  and  $\overline{OE} = V_{IL}$ ;  $\overline{CE}_1$ ,  $R/\overline{W}$ , and  $\overline{CNTNST} = V_{IH}$ .
2. If there is no address change via  $\overline{ADS} = V_{IL}$  (loading a new address) or  $\overline{CNTEN} = V_{IL}$  (advancing the address), i.e.  $\overline{ADS} = V_{IH}$  and  $\overline{CNTEN} = V_{IH}$ , then the data output remains constant for subsequent clocks.

## Timing Waveform of Write with Address Counter Advance (Flow-Through or Pipelined Outputs)<sup>(1)</sup>



## Timing Waveform of Counter Reset (Pipelined Outputs)<sup>(2)</sup>



### NOTES:

1.  $\overline{CE}_0$  and  $R/\overline{W} = V_{IL}$ ;  $CE_1$  and  $\overline{CNTRST} = V_{IH}$ .

2.  $\overline{CE}_0 = V_{IL}$ ;  $CE_1 = V_{IH}$ .

3. The "Internal Address" is equal to the "External Address" when  $\overline{ADS} = V_{IL}$  and equals the counter output when  $\overline{ADS} = V_{IH}$ .

4. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.

5. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.

6. No dead cycle exists during counter reset. A READ or WRITE cycle may be coincidental with the counter reset cycle.

7.  $\overline{CNTEN} = V_{IL}$  advances Internal Address from 'An' to 'An + 1'. The transition shown indicates the time required for the counter to advance. The 'An + 1' Address is written to during this cycle.

## A Functional Description

The IDT709189 provides a true synchronous Dual-Port Static RAM interface. Registered inputs provide minimal set-up and hold times on address, data, and all critical control inputs. All internal registers are clocked on the rising edge of the clock signal, however, the self-timed internal write pulse is independent of the LOW to HIGH transition of the clock signal.

An asynchronous output enable is provided to ease asynchronous bus interfacing. Counter enable inputs are also provided to stall the operation of the address counters for fast interleaved memory applications.

$\overline{CE_0} = V_{IH}$  or  $CE_1 = V_{IL}$  for one clock cycle will power down the internal circuitry to reduce static power consumption. Multiple chip enables allow easier banking of multiple IDT709189's for depth expansion configurations. When the Pipelined output mode is enabled, two cycles are required with  $\overline{CE_0} = V_{IL}$  and  $CE_1 = V_{IH}$  to re-activate the outputs.

## Depth and Width Expansion

The IDT709189 features dual chip enables (refer to Truth Table I) in order to facilitate rapid and simple depth expansion with no requirements for external logic. Figure 4 illustrates how to control the various chip enables in order to expand two devices in depth.

The 709189 can also be used in applications requiring expanded width, as indicated in Figure 4. Since the banks are allocated at the discretion of the user, the external controller can be set up to drive the input signals for the various devices as required to allow for 18-bit or wider applications.

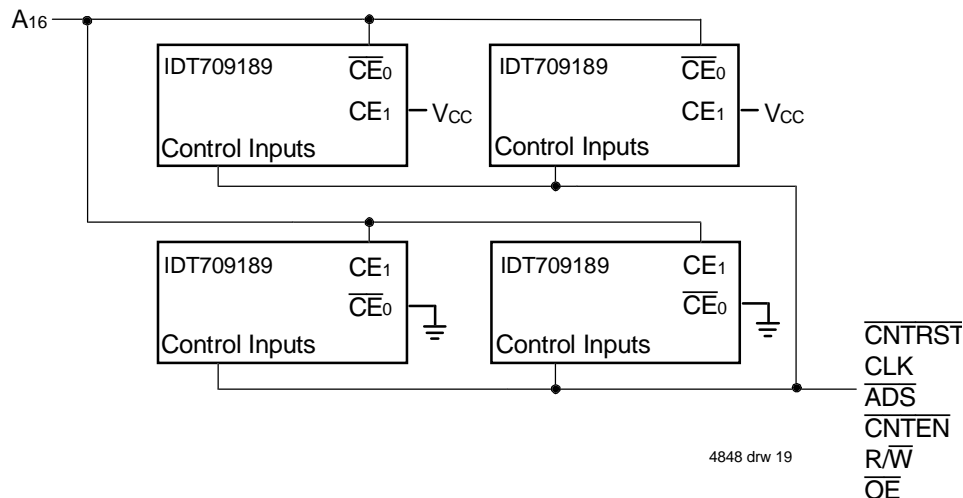


Figure 4. Depth and Width Expansion with IDT709189

## Ordering Information

| IDT | XXXXXX      | A     | 99    | A       | A                          |                                                          |                        |
|-----|-------------|-------|-------|---------|----------------------------|----------------------------------------------------------|------------------------|
|     | Device Type | Power | Speed | Package | Process/ Temperature Range |                                                          |                        |
|     |             |       |       |         | Blank I <sup>(1)</sup>     | Commercial (0°C to +70°C)<br>Industrial (-40°C to +85°C) |                        |
|     |             |       |       |         | PF                         | 100-pin TQFP (PN100-1)                                   |                        |
|     |             |       |       |         | 7<br>9<br>12               | Commercial Only<br>Commercial Only<br>Commercial Only    | } Speed in nanoseconds |
|     |             |       |       |         | L                          | Low Power                                                |                        |
|     |             |       |       |         | 709189                     | 576K (64K x 9-Bit) Synchronous Dual-Port RAM             |                        |

4848 drw 20

### NOTE:

1. Industrial temperature range is available.  
For specific speeds, packages and powers contact your sales office.

## Datasheet Document History

|           |                                                                           |
|-----------|---------------------------------------------------------------------------|
| 9/30/99:  | Initial Public Release                                                    |
| 11/10/99: | Replaced IDT logo                                                         |
| 12/22/99: | Page 1 Added missing diamond                                              |
| 1/12/01:  | Page 3 Changed information in Truth Table II                              |
|           | Page 4 Increased storage temperature parameter<br>Clarified TA parameter  |
|           | Page 5 DC Electrical parameters—changed wording from "open" to "disabled" |
|           | Changed ±200mV to 0mV in notes                                            |
|           | Removed Preliminary status                                                |



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